



T835-600G
T850-600G

HIGH PERFORMANCE TRIAC

FEATURES

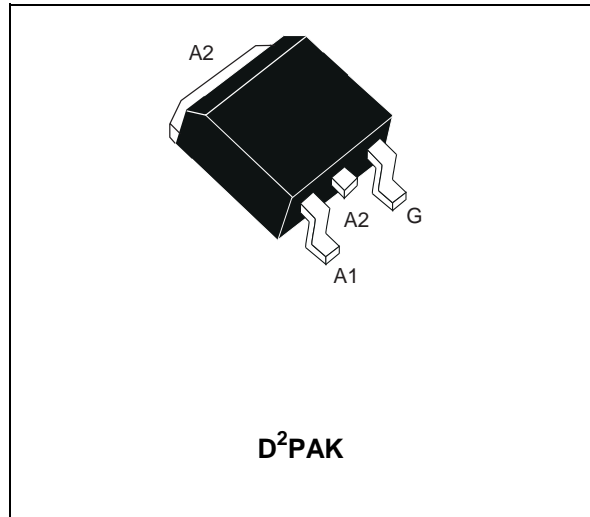
HIGH COMMUTATION PERFORMANCES
 SNUBBERLESS™ TECHNOLOGY
 HIGH NOISE IMMUNITY (dV/dt)
 HIGH I_{TSM}

DESCRIPTION

The T835-600G and T850-600G triacs are using high performance SNUBBERLESS technology.

They are intended for AC control applications using surface mount technology.

These devices are perfectly suited where high commutation and surge performances are required.



ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
V _{DRM} V _{RRM}	Repetitive peak off-state voltage	T _j = 125°C	600	V
I _{T(RMS)}	RMS on-state current (360° conduction angle)	T _c = 110°C	8	A
I _{TSM}	Non repetitive surge peak on-state current (T _j initial = 25°C)	t _p = 8.3ms	85	A
		t _p = 10 ms	80	
I ² t	I ² t Value for fusing	t _p = 10 ms	32	A ² s
dl/dt	Critical rate of rise of on-state current I _G = 500 mA dl _G /dt = 1 A/μs.	Repetitive F = 50 Hz	20	A/μs
		Non Repetitive	100	
T _{stg} T _j	Storage temperature range Operating junction temperature range		- 40, + 150 - 40, + 125	°C
T	Maximum temperature for soldering during 10s		260	°C

T835-600G / T850-600G

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
Rth(j-a)	Junction to ambient (S = 1 cm ²)	45	°C/W
Rth(j-c)	Junction to case for DC	2.1	°C/W
Rth(j-c)	Junction to case for AC 360° conduction angle (F=50Hz)	1.6	°C/W

GATE CHARACTERISTICS (maximum values)

$P_G (AV) = 1 \text{ W}$ $P_{GM} = 10 \text{ W}$ ($t_p = 20 \mu\text{s}$) $I_{GM} = 4 \text{ A}$ ($t_p = 20 \mu\text{s}$)

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions		Quadrant		T835	T850	Unit
I_{GT}	$V_D = 12\text{V (DC)}$ $R_L = 33\Omega$	$T_j = 25^\circ\text{C}$	I-II-III	MIN	2		mA
				MAX	35	50	
V_{GT}	$V_D = 12\text{V (DC)}$ $R_L = 33\Omega$	$T_j = 25^\circ\text{C}$	I-II-III	MAX	1.3		V
V_{GD}	$V_D = V_{DRM}$ $R_L = 3.3\text{k}\Omega$	$T_j = 125^\circ\text{C}$	I-II-III	MIN	0.2		V
I_H^*	$I_T = 100\text{mA}$ Gate open	$T_j = 25^\circ\text{C}$		MAX	35	50	mA
I_L	$I_G = 1.2 I_{GT}$	$T_j = 25^\circ\text{C}$	I-III	MAX	50	60	mA
			II	MAX	80	100	
V_{TM}^*	$I_{TM} = 11\text{A}$ $t_p = 380\mu\text{s}$	$T_j = 25^\circ\text{C}$		MAX	1.5		V
I_{DRM}	$V_D = V_{DRM}$	$T_j = 25^\circ\text{C}$		MAX	5		μA
I_{RRM}	$V_R = V_{RRM}$	$T_j = 125^\circ\text{C}$		MAX	2		mA
dV/dt^*	Linear slope up to $V_D = 67\% V_{DRM}$ Gate open	$T_j = 125^\circ\text{C}$		MIN	500	1000	$\text{V}/\mu\text{s}$
$(di/dt)_c^*$	Without snubber	$T_j = 125^\circ\text{C}$		MIN	4.5	7	A/ms

* For either polarity of electrode A2 voltage with reference to electrode A1.

ORDERING INFORMATION Add "-TR" suffix for Tape & Reel shipment

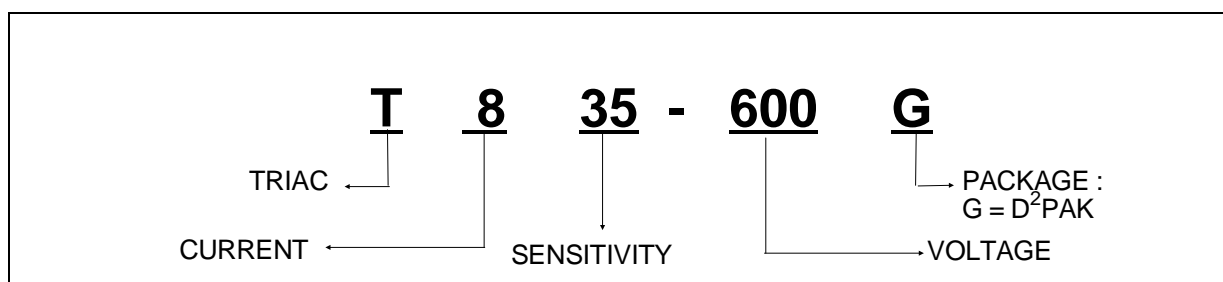


Fig. 1: Maximum power dissipation versus RMS on-state current.

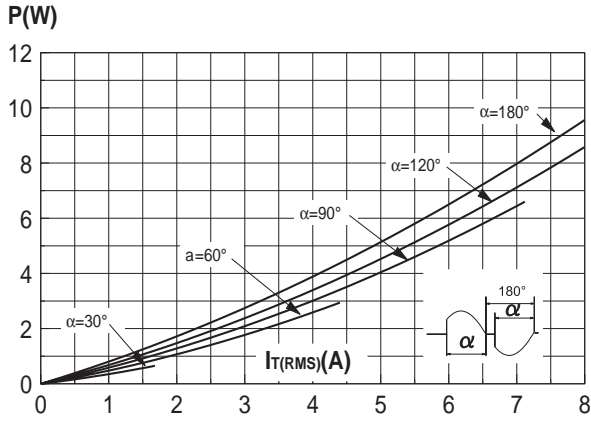


Fig. 2: Correlation between maximum power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink+contact.

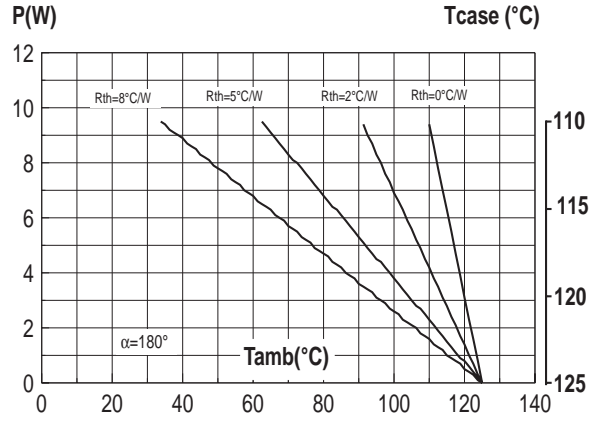


Fig. 3: RMS on-state current versus case temperature.

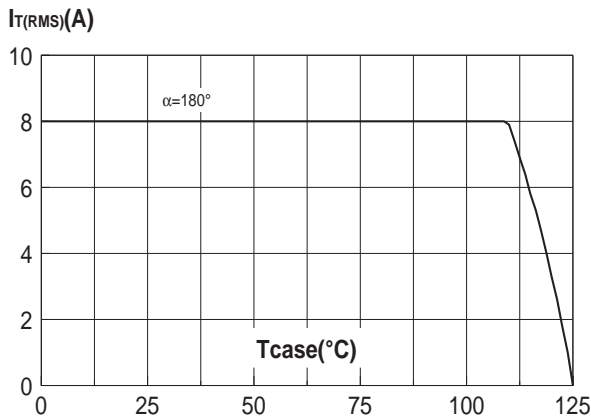


Fig. 4 : Relative variation of thermal impedance versus pulse duration.

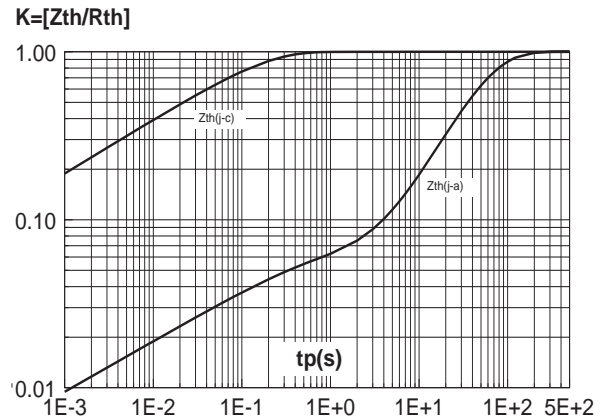


Fig. 5: Relative variation of gate trigger current and holding current versus junction temperature (typical values).

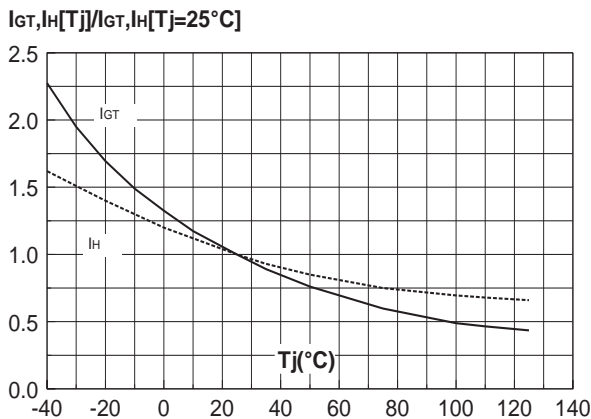


Fig. 6: Non repetitive surge peak on-state current versus number of cycles.

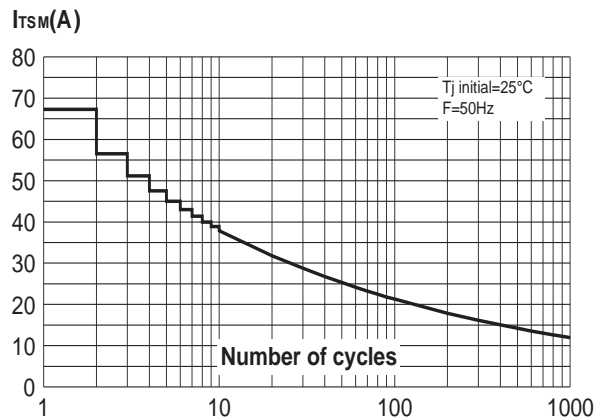


Fig. 7: Non repetitive surge peak on-state current for a sinusoidal pulse with width $t_p < 10\text{ms}$, and corresponding value of I^2t .

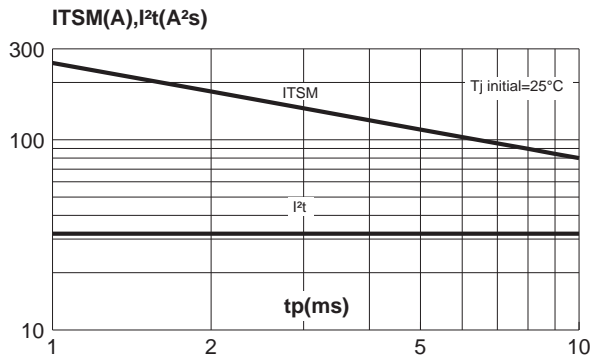


Fig. 9: Thermal resistance junction to ambient versus copper surface under tab (Epoxy printed circuit board FR4, copper thickness: $35\mu\text{m}$).

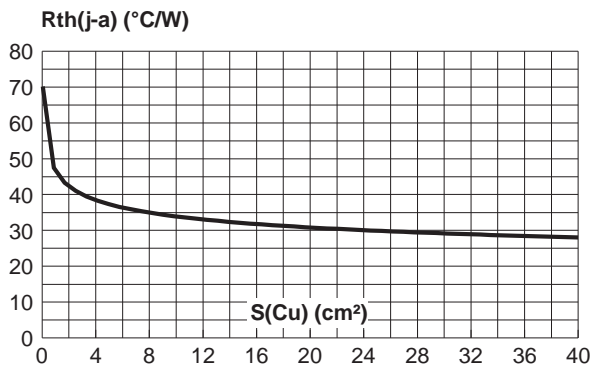


Fig. 8: On-state characteristics (maximum values).

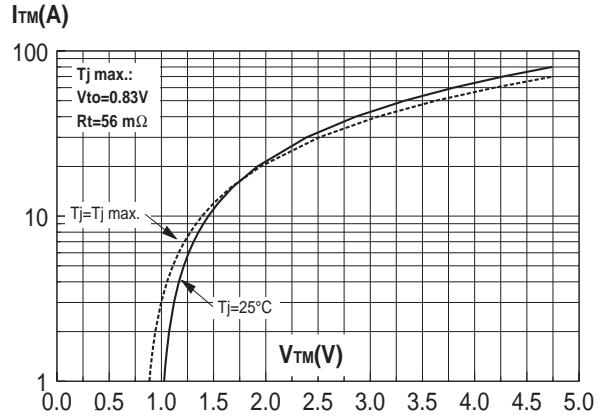
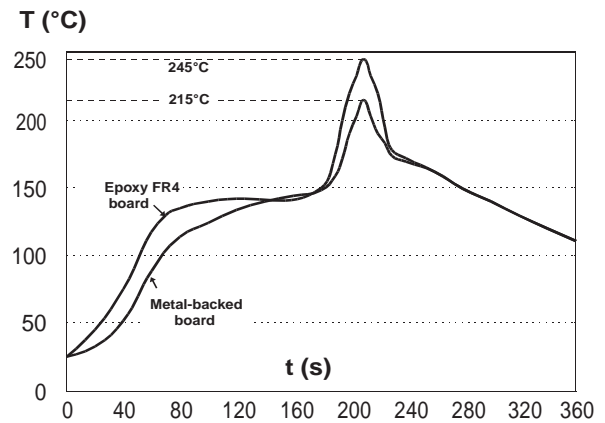
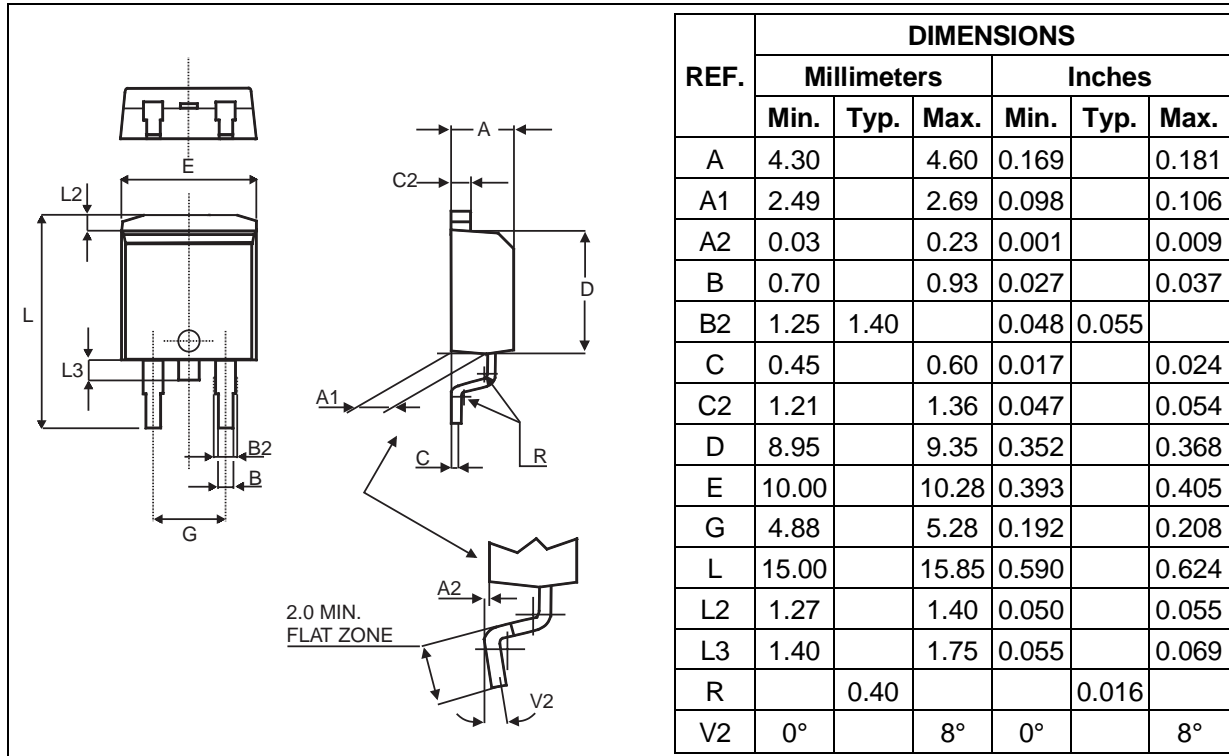


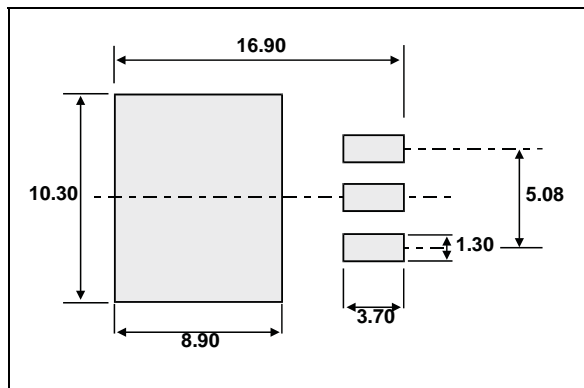
Fig. 10: Typical reflow soldering heat profile, either for mounting on FR4 or metal-backed boards.



PACKAGE MECHANICAL DATA
D²PAK



FOOT PRINT DIMENSIONS (in millimeters)



MARKING

TYPE	MARKING
T835-600G	T835 600G
T850-600G	T850 600G

PACKING

Tube : 50 units
Tape and reel : 500 units

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